Development of a Probabilistic Fatigue Life Model using AFGROW

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Motivation

- Increasing emphasis on reliable design of aircraft components
 - Design for six sigma
 - Understanding of performance at a specific risk level (e.g. p = 0.01)
- AFGROW has become a commonly used life prediction software (Harter, IJOF, 1999)
 - Applied to structures under spectrum loading (Barter et al., ASIP 2005, Huang et al., TAFM 2005, Zhang et al., IJOF 2003) and fretting fatigue (Giummarra, Trib., 2006)
- Nessus and Unipass are commercially available probabilistic software
 - Can probabilistic software be linked to AFGROW to create a design tool for predicting life of aircraft components?

Objective

- To develop a probabilistic interface for AFGROW using existing probabilistic software
- To demonstrate that the probabilistic interface can <u>accurately</u> and <u>efficiently</u> predict results
 - Modeling and comparison of experimental data

Outline

- Probabilistic interface for AFGROW
- Verification studies
 - CT specimen with variable material properties
 - SENT specimen with variable material properties and initial crack size
- Considerations
 - Various probabilistic methods
 - Sensitivity analysis highlights most important parameters
 - Comparison of Nessus and Unipass

Probabilistic Analysis - Overview

• Many variables affecting fatigue are not constant

- Material properties have scatter
 - Crack growth rate relation (da/dN versus ΔK)
 - Fracture toughness (K_{IC}) and yield strength (S_Y)
- Dimensions have tolerances
- Loading spectrums can vary depending on usage and conditions

General approach

- Represent variables as distributions in order to predict a distribution of performance
 - Variable interaction effects are included

Probabilistic Interface



AFGROW



- AFGROW life prediction software
 - Version 4.10.13 used in this study

Features

- Efficient weight function based K solutions
- Crack closure models
- Repair and inspection
- COM interface allows parametric study of design parameters using Excel
 - Utilized in probabilistic interface

Reliability Methods

- Monte Carlo simulation
 - Randomly generates parameter values from their distributions
 - Evaluates failure criteria, repeat for N trials
- Advantage: simple, robust, guaranteed to converge
- Disadvantage: computationally intensive

Reliability Methods

- Most probable point (MPP) methods (Haldar & Mahadevan, Wiley, 2000)
 - Optimization to find MPP
 - Distance to MPP relates to probability



Reliability Methods

- Mean value (MV): approximates MPP by perturbing variables near the mean
 - Number of trials = 1 + (number of variables)
- Advanced mean value (AMV): MV + additional evaluation at the MPP
 - Number of trials = 1 + (number of variables) + (number of p levels)
- FORM: various algorithms based on first order approximation of the performance function
 - Number of trials dependent on convergence
- Advantage: efficient, sensitivity factors
- Disadvantage: approximate, complex to implement, but available in probabilistic software packages

Model Verification #1 CT specimen

Verification of Model

 Data available for 30 constant amplitude fatigue tests on CT specimens of Al 2024-T351 (Wu & Ni, Prob Eng Mech, 2003)



- Probabilistic model
 - Identical geometry
 - Variability in fatigue crack growth rates, fracture toughness and yield strength
 - Yield strength affects crack closure

Probabilistic Model



AFGROW Model

- CT geometry based on ASTM Standard E647-93
 - W = 50 mm, B = 12 mm
 - Initial crack size = 15 mm
 - P_{max} = 4.5 kN, R = 0.2
- Modeled with FASTRAN II crack closure model

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$$\frac{\mathrm{da}}{\mathrm{dN}} = \mathrm{C}_{1} \Delta \mathrm{K}_{\mathrm{eff}}^{\mathrm{C}_{2}} \left[1 - \left(\Delta \mathrm{K}_{\mathrm{o}} / \Delta \mathrm{K}_{\mathrm{eff}} \right)^{2} \right]$$

- C_1 , C_2 from da/dN- ΔK_{eff} curve
- Effective threshold $\Delta K_o = 0.1 \text{ MPa-m}^{1/2}$
- Failure based on exceeding fracture toughness

Crack Growth Rate Relation

- Log-normal distribution for da/dN
- Mean based on piecewise curve (Newman et al., IJOF, 1999)
- Standard deviations from Wang (IJOF, 1999)
- da/dN curve moved from mean curve based on FCGR offset and standard deviation at each ΔK_{eff} value
- Accounts for specimen-tospecimen variation



Fracture Toughness

- AI 2024-T351 plate
- K_{lc} : μ = 34 MPa-m^{1/2} σ = 5.6 MPa-m^{1/2} (MIL-HDBK-5J)
- Assumed normal distribution (White et al., IJOF, 2005; Wang, Eng Fract Mech, 1995)



Yield Strength

- AI 2024-T351 plate
- YS: 331 MPa (A-basis) 345 MPa (B-basis) (MIL-HDBK-5J)
- A-basis: 99% of specimens with strength above this value
- B-basis: 90% of specimens with strength above this value
- Assumed log-normal distribution and computed shape (ζ) and scale (λ) parameters



- Experimental data (Wu and Ni, Prob Eng Mech, 2003)
- Life to failure
 - µ = 56,314 cycles
 - σ = 10,231 cycles



- Fit log-normal distribution to data
 - 5% and 95% bounds on mean curve
- Fit acceptable at 5% significance level (K-S test)



- Monte Carlo simulation
 - 1,000 trials
- Predicted (Unipass and Nessus)
 - µ = 52,000 cycles
 - σ = 4,000 cycles
- Experimental
 - μ = 56,314 cycles
 - σ = 10,231 cycles



- MV and AMV from Nessus
- FORM from Unipass
- AMV and FORM results within the MC sampling error
- Good agreement for critical shortest lives
- Long-life behavior not accurately modeled
 - Different mechanism?



Predicted Life at $P_f = 0.01$

Method	Life (cycles), P _f = 0.01	# of Trials	Time
N-MC-1k	42,697	1000	17 hrs
U-MC-1k	43,671	1000	16 hrs
N-MV	43,292	4	4 min
N-AMV	43,495	5	5 min
U-FORM	43,911	8	7 min

N=Nessus, U=Unipass

- AMV, MV and FORM give comparable results to MC in small fraction of time
- Best performance
 - AMV and MV methods in Nessus
 - FORM method in Unipass

Sensitivity Analysis

- Sensitivity factors are a measure of relative importance for each variable's contribution to scatter in life with respect to μ and σ
- Variability in CGR relation most important
- S_y and K_{IC} may be modeled as deterministic



Model Verification #2 SENT specimen

Verification of Model

- Data available for 24 constant amplitude fatigue tests on SENT specimens of Al 2024-T3 (Laz et al., IJOF, 2001; Newman et al., AGARD, 1988)
- Probabilistic model
 - Identical geometry
 - Variability in initial crack size, fatigue crack growth rates and yield strength
 - Initial crack size based on microstructural features
 - Yield strength affects crack closure

Probabilistic Model



AFGROW Model

SENT geometry

- W = 45 mm, L = 203 mm, B = 2.54 mm
- r = 2.813 mm, K_t = 3.165
- S_{max} = 120 MPa, R = 0
- Modeled with FASTRAN II crack closure model

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$$\frac{da}{dN} = C_1 \Delta K_{eff}^{c_2} \left[1 - \left(\Delta K_o / \Delta K_{eff} \right)^2 \right]$$

- C_1 , C_2 determined with da/dN- ΔK_{eff} curve
- Effective threshold $\Delta K_o = 0.1 \text{ MPa-m}^{1/2}$
- Failure based on life to breakthrough

Initial Crack Size Distribution

- Based on crack nucleating particles in AI 2024-T3 SENT specimens
 - Measured with replica techniques (Laz et al., IJOF, 2001)
- Log-normal distribution
 - Width 2a: μ = 8.95 μm
 σ = 4.10 μm
 - Depth c: μ = 13.6 μm
 σ = 5.58 μm
 - Correlation coefficient of 0.0359



• Experimental data

- Laz et al. (IJOF, 2001)
- Newman et al. (AGARD, 1988)
- Life to breakthrough
 - µ = 198,515 cycles
 - σ = 146,200 cycles



- Fit log-normal distribution to data
 - 5% and 95% bounds on mean curve
- Fit acceptable at 5% significance level (K-S test)



- Monte Carlo simulation
 - 1,000 trials
- Predicted (Unipass)
 - µ = 215,000 cycles
 - σ = 265,000 cycles
- Experimental
 - μ = 198,515 cycles
 - σ = 146,200 cycles



- MV and AMV from Nessus
- FORM from Unipass
- MV less accurate in regions away from mean
 - Limitation of method
- Very good agreement for AMV and FORM with MC



Predicted Life at $P_f = 0.01$

Method	Life to breakthrough (cycles), P _f = 0.01	# of Trials	Time
N-MC-1k	68,465	1000	1.3 hrs
U-MC-1k	72,864	1000	1.3 hrs
N-MV	24,035	5	17 sec
N-AMV	75,327	6	20 sec
U-FORM	73,505	10	40 sec

N=Nessus, U=Unipass

- Limitation of MV method often less accurate in tail regions
- AMV and FORM give comparable results to MC in small fraction of time

Sensitivity Analysis

- Life most sensitive to amount of variation in initial crack depth (c)
- CGR relation plays
 important role
- S_y may be modeled as deterministic



Probabilistic S-N Curve

- Fatigue life to fracture for the SENT specimen
- AMV method evaluated at multiple stress levels to compute 1% and 99% bounds
- Useful in design evaluation and risk assessment
- Computation time of 12
 minutes



Probabilistic S-N Curve

- Sensitivities depend on stress level (from AMV)
- Life was most sensitive to amount of variation σ in initial crack depth (c)
- CGR relation also an important factor



Increasing stress from 80 to 400 MPa

Discussion

- Interface developed to link probabilistic software (Nessus or Unipass) with AFGROW
 - Custom scripting utilized COM interface
 - While demonstrated here for lab fatigue tests, interface can be used with variability in any parameter available in AFGROW
- Efficient probabilistic methods accurately predicted the shortest fatigue lives in both experiments
 - AMV for Nessus, FORM for Unipass
- Probabilistic AFGROW analyses can provide important information for assessing risk of aircraft components
 - Efficient probabilistic methods can provide timely information for decision making



Thank you! Questions?



- C. Giummarra, J.R. Brockenbrough (2006). Fretting fatigue analysis using a fracture mechanics based small crack growth prediction method. Tribology International, 39, 1166-1171.
- S. Barter, M. McDonald and L. Molent (2005). Fleet fatigue life interpretation from full scale and coupon fatigue tests a simplified approach. In proceedings of the USAF Aircraft Structural Integrity Program conference, Memphis, TN.
- White, P., Molent, L., Barter, S. (2005). Interpreting fatigue test results using a probabilistic fracture approach. International Journal of Fatigue, 27, 752-767.
- X.P. Huang, J.B. Zhang, W.C. Cui, J.X. Leng (2005). Fatigue crack growth with overload under spectrum loading. Theoretical and Applied Fracture Mechanics, 44, 105-115.
- X. Zhang, Z. Wang (2003). Fatigue life improvement in fatigue-aged fastener holes using the cold expansion technique. International Journal of Fatigue, 25, 1249-1257.
- Wu, W.F. and Ni, C.C. (2003). A study if stochastic fatigue crack growth modeling through experimental data. Probabilistic Engineering Mechanics, 18, 107-118.
- MIL-HDBK-5J (2003). Metallic materials and elements for aerospace vehicle structures. Department of Defense Handbook. USA.
- Laz, P.J., Craig, B.A. and Hillberry, B.M. (2001). A probabilistic total fatigue life model incorporating material inhomogeneities, stress level and fracture mechanics. International Journal of Fatigue, 23, S119-S127.
- Haldar A. and Mahadevan S. Probability, Reliability and Statistical Methods in Engineering Design. John Wiley & Sons, Inc., New York, 2000.
- Wang G.S. (1999). A probabilistic damage accumulation solution based on crack closure model. International Journal of Fatigue, 21, 531-547.
- Newman, J.C. Jr., Phillips, E.P. and Swain, M.H. (1999). Fatigue-life prediction methodology using small-crack theory. International Journal of Fatigue, 21, 109-119.
- Newman, J.C., Jr. and Edwards, P.C. (1988). Short Crack Growth Behaviour in an Aluminum Alloy. *AGARD R-732*.
- Newman, J.C., Jr. FASTRAN II. NASA-TM-104159, 1992.
- NESSUS, Version 8.30 (Build 25). Southwest Research Institute, 2005.
- UNIPASS, Version 5.62. Prediction Probe, Inc, 2006.
- AFGROW, Version 4.10.13.0, Air Force Research Laboratories, 2006.